

# **Notice of References Cited**

Application/Control No.

10/049,645

Applicant(s)/Patent Under  
Reexamination  
MIYACHI ET AL.

Examiner

Rebecca L. Anderson

Art Unit

1626

Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number	Date	Name	Classification
		Country Code-Number-Kind Code	MM-YYYY		
	A	US-5,223,522	06-1993	Clark et al.	514/369
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number	Date	Country	Name	Classification
		Country Code-Number-Kind Code	MM-YYYY			
	N	EP 0 846 693	06-1998	Europe	Maeda et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.